











TPS22920, TPS22920L

SLVSAY8D -JUNE 2011-REVISED JANUARY 2016

# TPS22920x 3.6-V, 4-A, 5.3-mΩ On-Resistance, Integrated Load Switch with Controlled Turn-on

## **Features**

- Input Voltage Range: 0.75 V to 3.6 V
- Integrated Load Switch
- Integrated Pass-FET  $r_{DSON} = 2 \text{ m}\Omega$  (Typ) at 3.6 V
- Typical ON-Resistance
  - $r_{ON} = 5.3 \text{ m}\Omega \text{ at } V_{IN} = 3.6 \text{ V}$
  - $r_{ON}$  = 5.4  $m\Omega$  at  $V_{IN}$  = 2.5 V
  - r<sub>ON</sub> = 5.5 mΩ at V<sub>IN</sub> = 1.8 V
  - $r_{ON} = 5.8 \text{ m}\Omega$  at  $V_{IN} = 1.2 \text{ V}$
  - $r_{ON} = 6.1 \text{ m}\Omega \text{ at } V_{IN} = 1.05 \text{ V}$
  - $r_{ON} = 7.3 \text{ m}\Omega \text{ at } V_{IN} = 0.75 \text{ V}$
- CSP-8 Package 0.9 mm x 1.9 mm, 0.5 mm Pitch
- 4-A Maximum Continuous Switch Current
- Shutdown Current 5.5-µA Max
- ON-Logic Available in Both Active High/Low:
  - TPS22920 is Active High
  - TPS22920L is Active Low
- Low Threshold Control Input
- Controlled Slew-Rate to Avoid Inrush Current
- **Quick Output Discharge Resistor**
- ESD Performance Tested Per JESD 22
  - 4000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)

# Applications

- Notebook / Netbook Computer
- **Tablet PC**
- PDAs / Smartphones
- **GPS Navigation Devices**
- MP3 Players

# 3 Description

The TPS22920x is a small, space-saving load switch with controlled turn on to reduce inrush current. The device contains a N-channel MOSFET that can operate over an input voltage range of 0.75 V to 3.6 V and switch currents up to 4 A. An integrated charge pump biases the NMOS switch in order to achieve a minimum switch ON resistance (r<sub>ON</sub>). The switch is controlled by an on/off input (ON), which is capable of interfacing directly with low-voltage control signals.

The TPS22920x has a 1250-Ω on-chip resistor for quick output discharge when the switch is turned off which insures that the output is not left floating.

The TPS22920x has an internally controlled rise time in order to reduce inrush current.

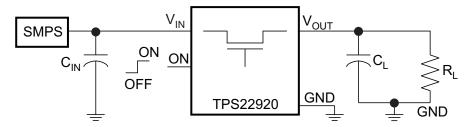
The TPS22920x is available in an ultra-small, spacesaving 8-pin CSP package and is characterized for operation over the free-air temperature range of -40°C to 85°C.

# Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPS22920x	DSBGA (8)	1.90 mm x 0.90 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

#### **Typical Application**





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F S	Added Pin Configuration and Functions section, Handling Ra Functional Modes, Application and Implementation section, F ection, Device and Documentation Support section, and Me ection	Power S echanica	upply Recommendations section, Layout I, Packaging, and Orderable Information	······································
Cha	nges from Original (June 2011) to Revision A			Page

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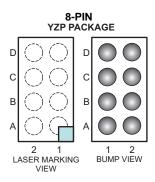


# 5 Device Comparison Table

ORDERABLE PART NUMBER	R <sub>ON</sub> (TYP) AT 3.6 V	RISE TIME (TYP) at 3.6V	QUICK OUTPUT DISCHARGE <sup>(1)</sup>	BACKSIDE COATING <sup>(2)</sup>	ENABLE
TPS22920YZPR	5.3 mΩ	880 µS	Yes	No	Active High
TPS22920YZPRB	5.3 mΩ	880 µS	Yes	Yes	Active High
TPS22920LYZPR	5.3 mΩ	627 µS	Yes	Yes	Active Low

<sup>(1)</sup> This feature discharges the output of the switch to ground through a 1250-Ω resistor, preventing the output from floating. See Output Pull-Down.

# 6 Pin Configuration and Functions



#### **Pin Functions**

PIN 1/4		I/O	DESCRIPTION
NAME	NO.	1/0	DESCRIPTION
GND	D1	-	Ground
ON	D2	I	Switch control input. Do not leave floating
V <sub>OUT</sub>	A1, B1, C1	0	Switch output
V <sub>IN</sub>	A2, B2, C2	I	Switch input, bypass this input with a ceramic capacitor to ground

#### Table 1. Bump Assignments (YZP Package)

D	GND	ON
С	V <sub>OUT</sub>	V <sub>IN</sub>
В	V <sub>OUT</sub>	V <sub>IN</sub>
A	V <sub>OUT</sub>	V <sub>IN</sub>
	1	2

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<sup>(2)</sup> CSP (DSBGA) devices manufactured with backside coating have an increased resistance to cracking due to the increased physical strength of the package. Devices with backside coating are highly encouraged for new designs.



# 7 Specifications

# 7.1 Absolute Maximum Ratings<sup>(1)</sup>

		MIN	MAX	UNIT
$V_{IN}$	Input voltage range	-0.3	4	V
V <sub>OUT</sub>	Output voltage range		VIN + 0.3	V
$V_{ON}$	Input voltage range	-0.3	4	V
I <sub>MAX</sub>	Maximum Continuous Switch Current		4	Α
I <sub>PLS</sub>	Maximum Pulsed Switch Current, pulse <300 μS, 2% duty cycle		6	Α
$T_{J}$	Maximum junction temperature		125	°C
T <sub>stg</sub>	Storage temperature range	-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 7.2 ESD Ratings

			VALUE	UNIT
V	V 51 4 6 6 1	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±4000	.,
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	±1000	V

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 500-V HBM is possible with the necessary precautions.

# 7.3 Recommended Operating Conditions

			MIN	MAX	UNIT
$V_{IN}$	Input voltage range		0.75	3.6	V
$V_{OUT}$	Output voltage range			$V_{IN}$	V
V	High lovel input voltage ON	V <sub>IN</sub> = 2.5 V to 3.6 V	1.2	3.6	V
$V_{IH}$	High-level input voltage, ON	V <sub>IN</sub> = 0.75 V to 2.49 V	0.9	3.6	٧
.,		V <sub>IN</sub> = 2.5 V to 3.6 V		0.6	٧
V <sub>IL</sub>	Low-level input voltage, ON	V <sub>IN</sub> = 0.75 V to 2.49 V		0.4	٧
$T_A$	Operating free-air temperature	range	-40	85	ů
C <sub>IN</sub>	Input Capacitor		1 <sup>(1)</sup>		μF

<sup>(1)</sup> See Input Capacitor section in Application Information.

#### 7.4 Thermal Information

		TPS22920x	
	THERMAL METRIC <sup>(1)</sup>	YZP	UNIT
		8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	130	
R <sub>0</sub> JC(top)	Junction-to-case (top) thermal resistance	54	
$R_{\theta JB}$	Junction-to-board thermal resistance	51	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	1	
ΨЈВ	Junction-to-board characterization parameter	50	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

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<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 250-V CDM is possible with the necessary precautions.



#### 7.5 Electrical Characteristics

Unless otherwise noted,  $V_{IN} = 0.75 \text{ V}$  to 3.6 V

	PARAMETER	TEST	CONDITIONS	T <sub>A</sub>	MIN TYP(1)	MAX	UNIT
			V <sub>IN</sub> = 3.6 V		68	160	^
			$V_{IN} = 2.5 \text{ V}$		40	70	μA
	Ovice and Comment	I <sub>OUT</sub> = 0, Switch	V <sub>IN</sub> = 1.8 V		25	350	
I <sub>IN</sub>	Quiescent Current	enabled	V <sub>IN</sub> = 1.2 V	Full	103	200	μA
			$V_{IN} = 1.05 V$		78	110	
			$V_{IN} = 0.75 V$		37	70	μA
I <sub>IN(leak)</sub>	Off Supply Current (After Pull Down)	Switch disabled, V	OUT = 0	Full		5.5	μΑ
		V <sub>IN</sub> = 3.6 V, I <sub>OUT</sub> = -200 mA		25°C	5.3	8.8	0
				Full		9.8	mΩ
		V <sub>IN</sub> = 2.5 V, I <sub>OUT</sub> = -200 mA		25°C	5.4	8.9	mΩ
				Full		9.9	
		V <sub>IN</sub> = 1.8 V, I <sub>OUT</sub> = -200 mA		25°C	5.5	9.1	mΩ mΩ
	On-Resistance			Full		10.1	
r <sub>ON</sub>	On-Resistance	V <sub>IN</sub> = 1.2 V, I <sub>OUT</sub> = -200 mA		25°C	5.8	9.4	
				Full		10.4	
		V <sub>IN</sub> = 1.05 V, I <sub>OUT</sub>	- 200 m A	25°C	6.1	9.7	mO.
		$v_{IN} = 1.05 \text{ v}, I_{OUT}$	= -200 IIIA	Full		10.8	mΩ
		V <sub>IN</sub> = 0.75 V, I <sub>OUT</sub>	- 200 m A	25°C	7.3	11.0	mΩ
		VIN = 0.75 V, IOUT	= -200 IIIA	Full		12.4	11122
RPD	Output pull down resistance <sup>(2)</sup>	V <sub>IN</sub> = 3.3 V, Switch	n disabled, I <sub>OUT</sub> = 3 mA	Full	1250	1500	Ω
I <sub>ON</sub>	ON input leakage current	$V_{ON} = 0.9 \text{ V to } 3.6$	V or GND	Full		0.1	μΑ

<sup>(1)</sup> Typical values are at  $V_{IN}$  = 3.3 V and  $T_A$  = 25°C. (2) See *Output Pull-Down* .

# 7.6 Switching Characteristics: $V_{IN} = 3.6 \text{ V}$

 $T_A = 25^{\circ}C$  (unless otherwise noted)

	PARAMETER TEST CONDITION		TPS22920	TPS22920L	UNIT
			TYP	TYP	UNIT
t <sub>ON</sub>	Turn-ON time	$R_L = 10~\Omega,~C_L = 0.1~\mu F,~V_{IN} = 3.6~V$	970	663	
t <sub>OFF</sub>	Turn-OFF time	$R_L=10~\Omega,~C_L=0.1~\mu F,~V_{IN}=3.6~V$	3	2	
t <sub>r</sub>	VOUT Rise time	$R_L = 10~\Omega,~C_L = 0.1~\mu F,~V_{IN} = 3.6~V$	880	627	μs
t <sub>f</sub>	VOUT Fall time	$R_L = 10~\Omega,~C_L = 0.1~\mu F,~V_{IN} = 3.6~V$	2	2	

# 7.7 Switching Characteristics: $V_{IN} = 0.9 \text{ V}$

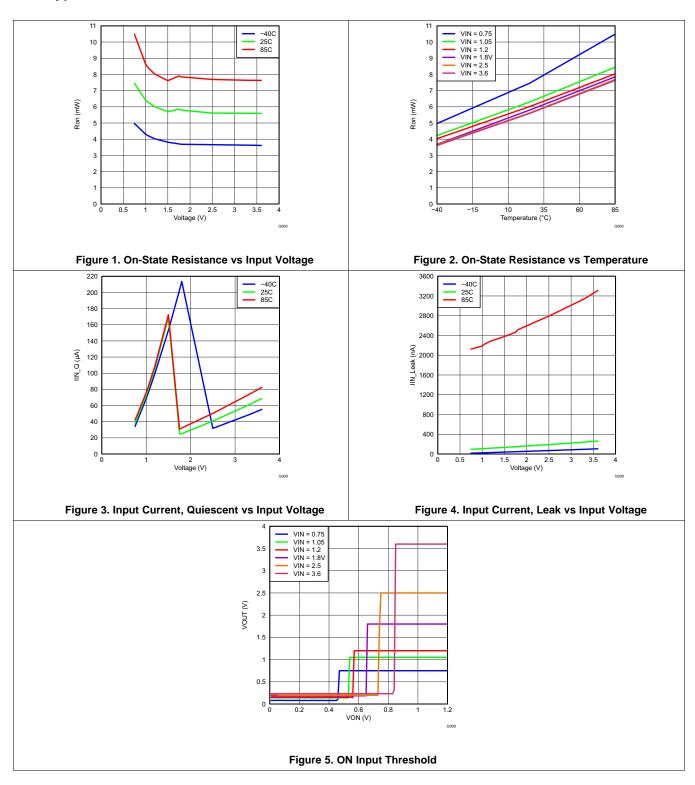
 $T_A = 25^{\circ}C$  (unless otherwise noted)

DADAMETED		TEST CONDITION	TPS22920	TPS22920L	LIMIT
	PARAMETER	TEST CONDITION	TYP	TYP	UNIT
t <sub>ON</sub>	Turn-ON time	$R_L = 10 \ \Omega, \ C_L = 0.1 \ \mu F, \ V_{IN} = 0.9 \ V$	840	840	
t <sub>OFF</sub>	Turn-OFF time	$R_L = 10 \Omega$ , $C_L = 0.1 \mu F$ , $V_{IN} = 0.9 V$	16	16	
t <sub>r</sub>	VOUT Rise time	$R_L = 10 \Omega$ , $C_L = 0.1 \mu F$ , $V_{IN} = 0.9 V$	470	470	μs
t <sub>f</sub>	VOUT Fall time	$R_L = 10 \ \Omega, \ C_L = 0.1 \ \mu F, \ V_{IN} = 0.9 \ V$	5	5	

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# 7.8 Typical DC Characteristics

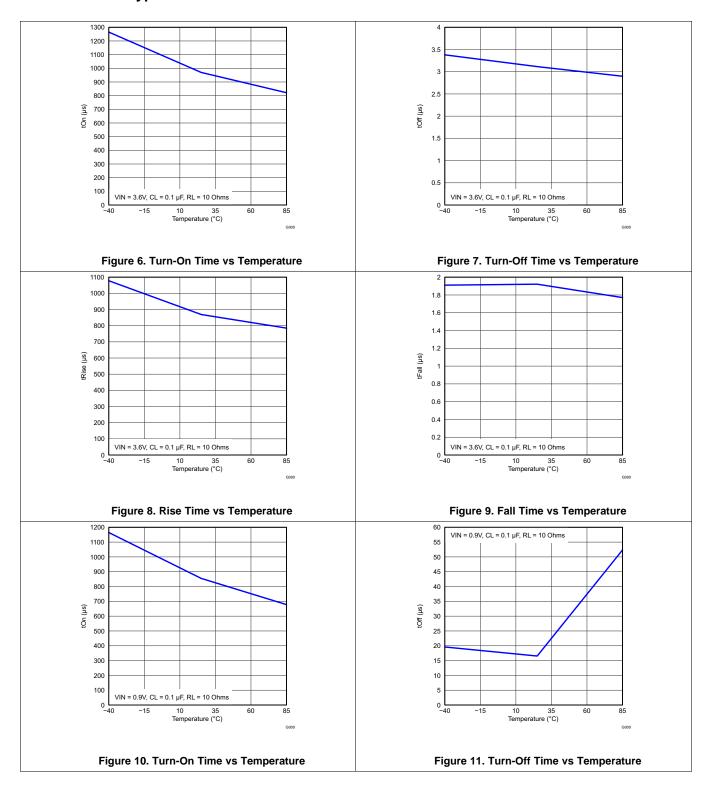


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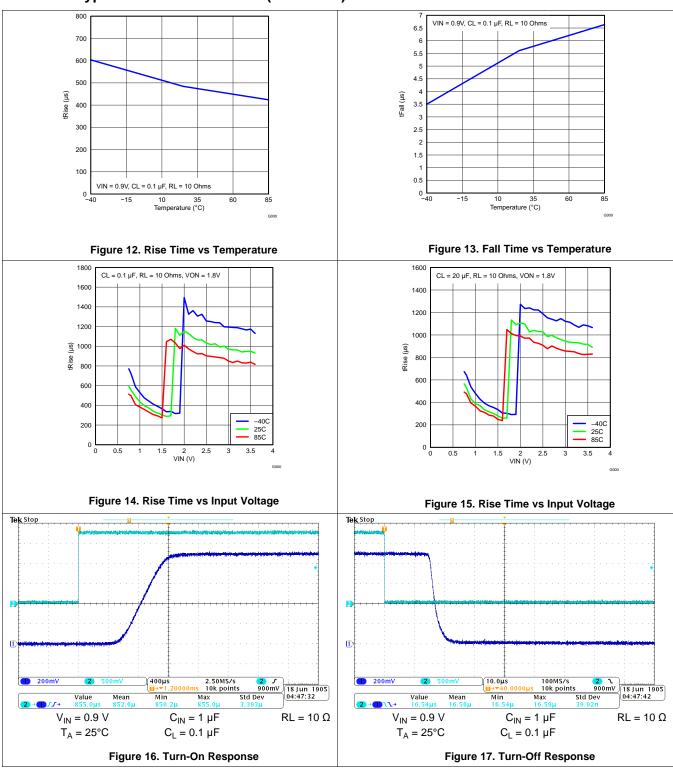


# 7.9 TPS22920 Typical AC Characteristics



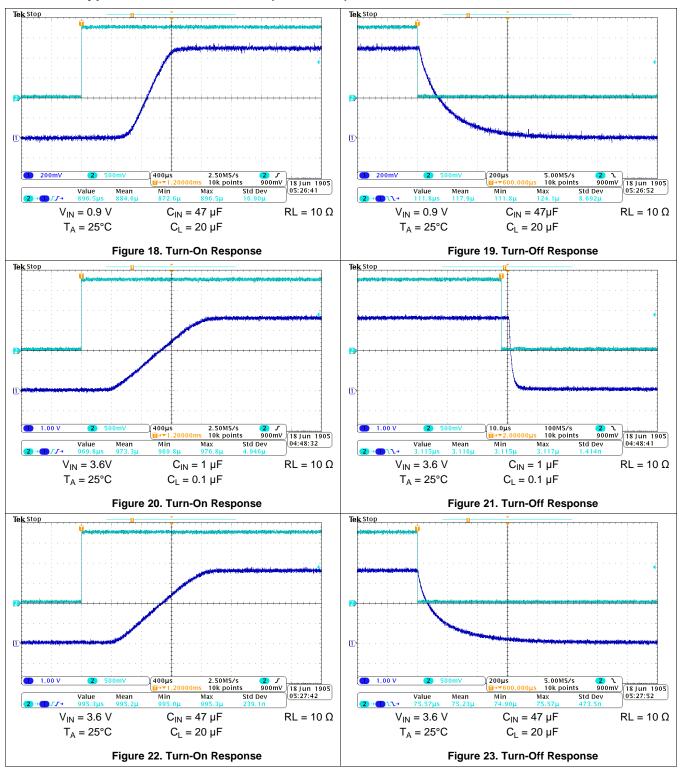
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# **TPS22920 Typical AC Characteristics (continued)**



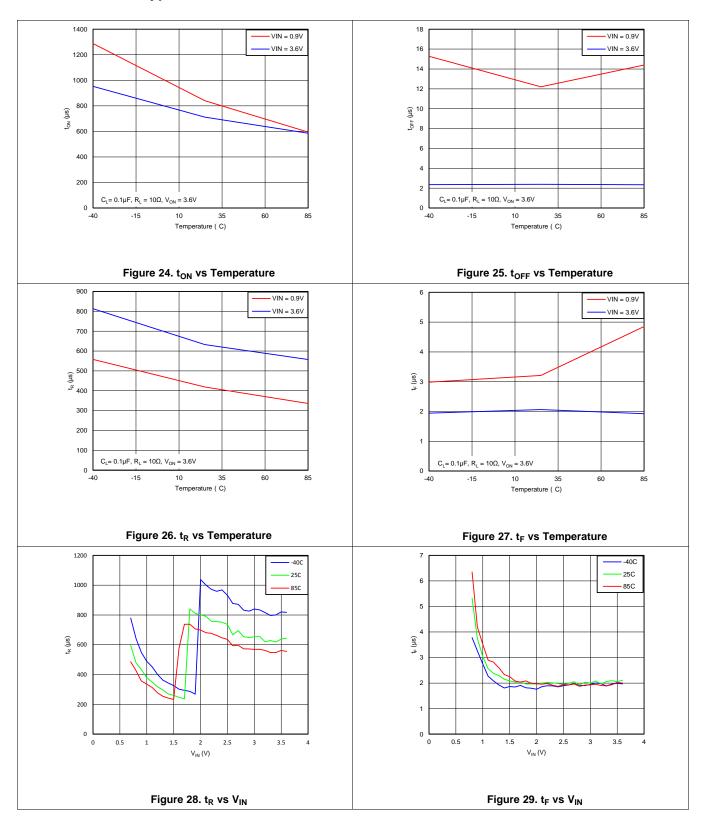


# **TPS22920 Typical AC Characteristics (continued)**



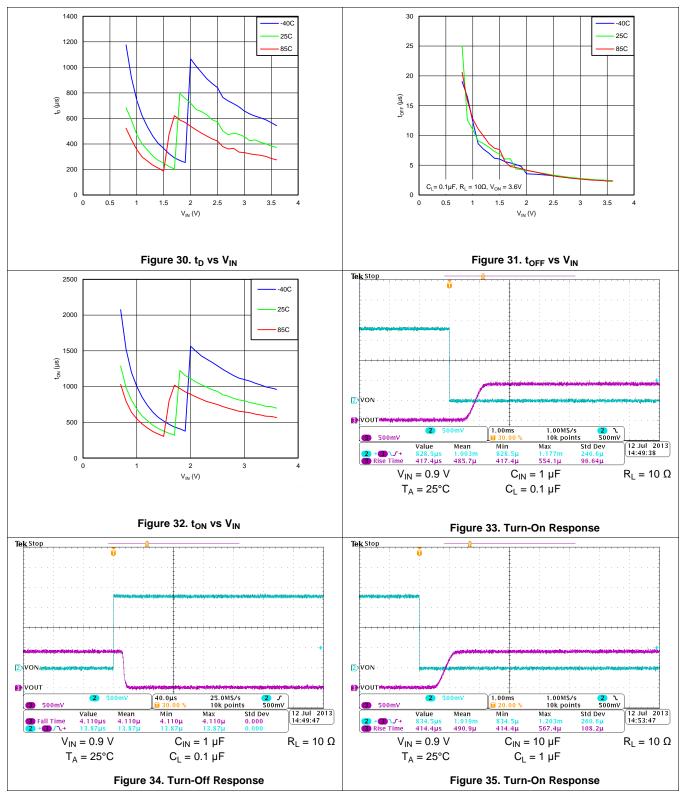


# 7.10 TPS22920L Typical AC Characteristics



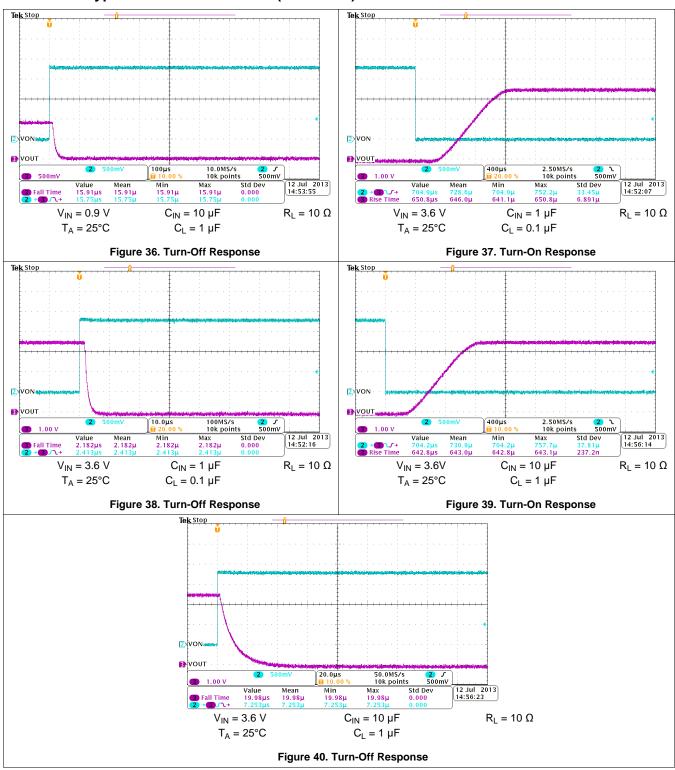


# **TPS22920L Typical AC Characteristics (continued)**





## **TPS22920L Typical AC Characteristics (continued)**

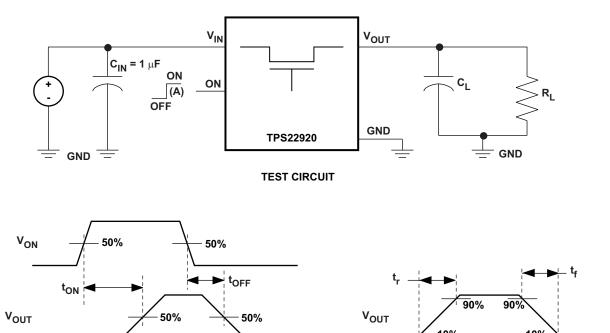


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# 8 Parametric Measurement Information



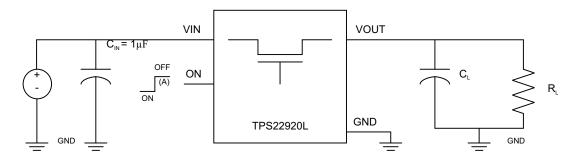
 $t_{ON}/t_{OFF}$  WAVEFORMS

(A) Rise and fall times of the control signal is 100 ns.

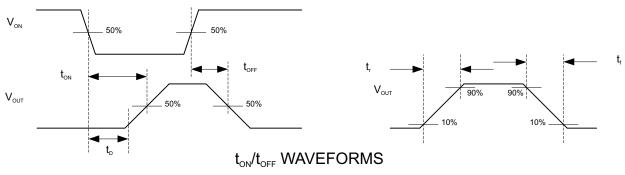
Figure 41. TPS22920 Test Circuit and  $\rm T_{ON}\!/T_{OFF}$  Waveforms



# **Parametric Measurement Information (continued)**



# **TEST CIRCUIT**



A. Rise and fall times of the control signal is 100ns.

Figure 42. TPS22920L Test Circuit and  $t_{\text{ON}}/t_{\text{OFF}}$  Waveforms

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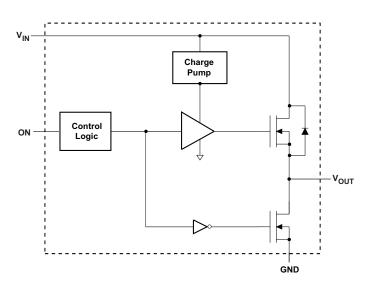
# 9 Detailed Description

#### 9.1 Overview

The TPS22920x is a single channel, 4-A load switch in a small, space-saving CSP-8 package. This device implements a low resistance N-channel MOSFET with a controlled rise time for applications that need to limit the inrush current.

This device is also designed to have very low leakage current during off state, which prevents downstream circuits from pulling high standby current from the supply. Integrated control logic, driver, power supply, and output discharge FET eliminates the need for additional external components, which reduces solution size and bill of materials (BOM) count.

## 9.2 Functional Block Diagram



#### 9.3 Feature Description

#### 9.3.1 ON/OFF Control

The ON pin controls the state of the switch. For TPS22920, asserting ON high enables the switch. For TPS22920L, asserting ON low enables the switch. ON has a low threshold, making it capable of interfacing with low-voltage signals. The ON pin is compatible with standard GPIO logic threshold. It can be used with any microcontroller with 1.2-V, 1.8-V, 2.5-V or 3.3-V GPIOs.

## 9.3.2 Output Pull-Down

The output pull-down is active when the user is turning off the main pass FET. The pull-down discharges the output rail to approximately 10% of the rail, and then the output pull-down is automatically disconnected to optimize the shutdown current.

#### 9.4 Device Functional Modes

ON	TPS2	22920	TPS22920L			
	V <sub>IN</sub> to V <sub>OUT</sub>	V <sub>OUT</sub> to GND <sup>(1)</sup>	V <sub>IN</sub> to V <sub>OUT</sub>	V <sub>OUT</sub> to GND <sup>(1)</sup>		
Logic Low	OFF	ON	ON	OFF		
Logic High	ON	OFF	OFF	ON		

(1) See Output Pull-Down.



## 10 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

# 10.1 Application Information

#### 10.1.1 Input Capacitor

To limit the voltage drop on the input supply caused by transient inrush currents when the switch turns on into a discharged load capacitor or short-circuit, a capacitor needs to be placed between  $V_{IN}$  and GND. A 1- $\mu$ F ceramic capacitor,  $C_{IN}$ , placed close to the pins is usually sufficient. Higher values of  $C_{IN}$  can be used to further reduce the voltage drop.

## 10.1.2 Output Capacitor

A  $C_{IN}$  greater than  $C_L$  is highly recommended due to the integral body diode in the NMOS switch. A  $C_L$  greater than  $C_{IN}$  can cause  $V_{OUT}$  to exceed VIN when the system supply is removed. This could result in current flow through the body diode from  $V_{OUT}$  to  $V_{IN}$ . A  $C_{IN}$  to  $C_L$  ratio of 10 to 1 is recommended for minimizing  $V_{IN}$  dip caused by inrush currents during startup.

## 10.2 Typical Application

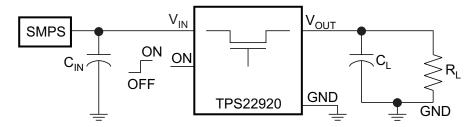


Figure 43. Typical Application Circuit

#### 10.2.1 Design Requirements

DESIGN PARAMETER	EXAMPLE VALUE
V <sub>IN</sub>	3.3 V
$C_L$	4.7 μF
Maximum Acceptable Inrush Current	40 mA

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#### 10.2.2 Detailed Design Procedure

#### 10.2.2.1 VIN to VOUT Voltage Drop

The VIN to VOUT voltage drop in the device is determined by the  $R_{ON}$  of the device and the load current. The  $R_{ON}$  of the device depends upon the VIN condition of the device. Refer to the  $R_{ON}$  specification of the device in the *Electrical Characteristics* table of this datasheet. Once the  $R_{ON}$  of the device is determined based upon the VIN conditions, use Equation 1 to calculate the VIN to VOUT voltage drop:

$$\Delta V = I_{LOAD} \times R_{ON}$$

#### where

- ΔV = Voltage drop from VIN to VOUT
- I<sub>LOAD</sub> = Load current
- R<sub>ON</sub> = On-resistance of the device for a specific V<sub>IN</sub>
- An appropriate I<sub>LOAD</sub> must be chosen such that the I<sub>MAX</sub> specification of the device is not violated.

#### 10.2.2.2 Managing Inrush Current

The output capacitors must be charged up from 0-V to V<sub>IN</sub> when the switch is enabled. This charge arrives in the form of inrush current. Inrush current may be calculated using the following equation:

Inrush Current = 
$$C \times \frac{dv}{dt}$$

#### where

• C = Output capacitance

• 
$$\frac{dv}{dt}$$
 = Output slew rate (2)

The TPS22920x offers a very slow controlled rise time for minimizing inrush current. This device can be selected based upon the maximum acceptable slew rate which can be calculated using the design requirements and the inrush current equation. An output capacitance of 4.7 µF will be used since the amount of inrush increases with output capacitance:

$$40\text{mA} = 4.7\mu\text{F} \times \frac{\text{dv}}{\text{dt}} \tag{3}$$

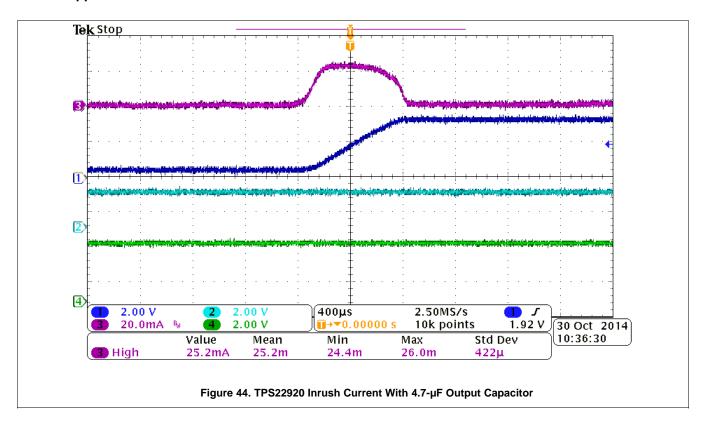
$$\frac{dv}{dt} = 8.5V/ms \tag{4}$$

A device with a slew rate less than 8.5 V/ms must be used to ensure an inrush current of less than 40 mA.

The TPS22920 has a typical rise time of 880 µs at 3.3 V. This results in a slew rate of 3.75 V/ms which meets the *Design Requirements*.



## 10.2.3 Application Curves



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# 11 Power Supply Recommendations

The device is designed to operate from a VIN range of 0.75 V to 3.6 V. The VIN power supply must be well regulated and placed as close to the VIN terminal as possible. The power supply must be able to withstand all transient load current steps. In most situations, using the minimum recommended input capacitance of 1  $\mu$ F is sufficient to prevent the supply voltage from dipping when the switch is turned on. In cases where the power supply is slow to respond to a large transient current or large load current step, additional bulk capacitance may be required on the input.

## 12 Layout

# 12.1 Layout Guidelines

All traces should be as short as possible for best performance. The input and output capacitors must be placed close to the device to minimize the effects that parasitic trace inductances may have on normal operation. Using wide traces for  $V_{\text{IN}}$ ,  $V_{\text{OUT}}$ , and GND helps minimize the parasitic electrical effects along with minimizing the case to ambient thermal impedance.

# 12.2 Layout Example

VIA to Power Ground Plane

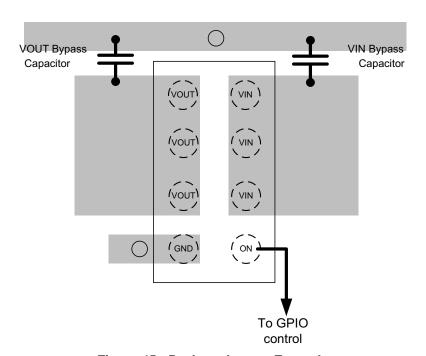


Figure 45. Package Layout Example



# 13 Device and Documentation Support

#### 13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 2. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
TPS22920	Click here	Click here	Click here	Click here	Click here	
TPS22920L	Click here	Click here	Click here	Click here	Click here	

#### 13.2 Trademarks

All trademarks are the property of their respective owners.

## 13.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 13.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing		Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TPS22920LYZPR	ACTIVE	DSBGA	YZP	8	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	DV	Samples
TPS22920LYZPT	ACTIVE	DSBGA	YZP	8	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	DV	Samples
TPS22920YZPR	ACTIVE	DSBGA	YZP	8	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	6Z	Samples
TPS22920YZPRB	ACTIVE	DSBGA	YZP	8	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	6Z S	Samples
TPS22920YZPT	ACTIVE	DSBGA	YZP	8	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	6Z	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



# **PACKAGE OPTION ADDENDUM**

19-Jan-2016

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE MATERIALS INFORMATION**

www.ti.com 17-May-2018

# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS22920LYZPR	DSBGA	YZP	8	3000	180.0	8.4	1.02	2.02	0.63	4.0	8.0	Q1
TPS22920LYZPT	DSBGA	YZP	8	250	180.0	8.4	1.02	2.02	0.63	4.0	8.0	Q1
TPS22920YZPR	DSBGA	YZP	8	3000	180.0	8.4	1.02	2.02	0.63	4.0	8.0	Q1
TPS22920YZPRB	DSBGA	YZP	8	3000	180.0	8.4	1.02	2.02	0.63	4.0	8.0	Q1
TPS22920YZPT	DSBGA	YZP	8	250	180.0	8.4	1.02	2.02	0.63	4.0	8.0	Q1

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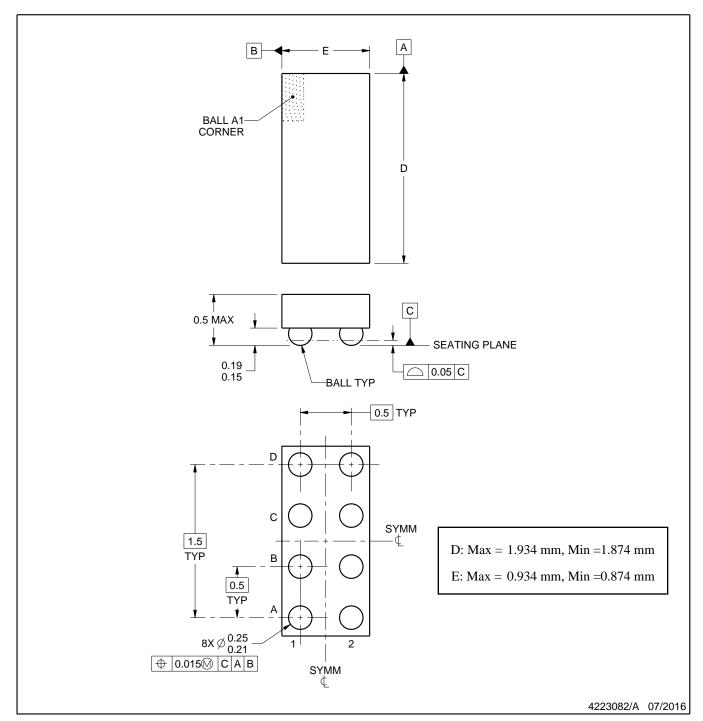


\*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS22920LYZPR	DSBGA	YZP	8	3000	182.0	182.0	20.0
TPS22920LYZPT	DSBGA	YZP	8	250	182.0	182.0	20.0
TPS22920YZPR	DSBGA	YZP	8	3000	182.0	182.0	20.0
TPS22920YZPRB	DSBGA	YZP	8	3000	182.0	182.0	20.0
TPS22920YZPT	DSBGA	YZP	8	250	182.0	182.0	20.0



DIE SIZE BALL GRID ARRAY



## NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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